# EMC TEST REPORT

| | | |
|---|---|---|
| **Application No.** | : | HX260102700072 |
| **Applicant** | : | LANGFANG LIUTAI FURNITURE CO., LTD |
| **Equipment Under Test (EUT)** | | |
| **EUT Name** | : | LED strip remote control |
| **Model No.** | : | LB-01 |
| **Serial No.** | : | N/A |
| **Trademark** | : | N/A |
| **Receipt Date** | : | 2026-01-13 |
| **Test Date** | : | 2026-01-13 to 2026-01-21 |
| **Issue Date** | : | 2026-01-21 |
| **Standards** | : | EN IEC 55015: 2019/A11: 2020;<br>EN IEC 61547:2023. |
| **Conclusions** | : | **PASS** |

In the configuration tested, the EUT complied with the standards specified above. The EUT technically complies with the 2014/30/EU directive requirements.

**Test/Witness Engineer** : Larry Su

**Approved & Authorized** : Edward Zhao

This report details the results of the testing carried out on one sample. The results contained in this test report do not relate to other samples of the same product. The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in the report.

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# 1. General Information

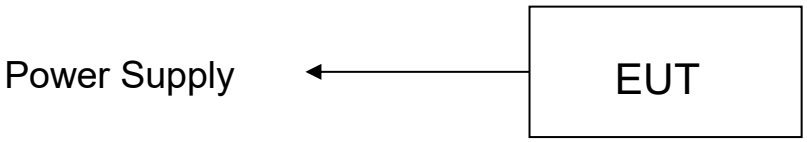
## 1.1. Client Information

| | | |
|---|---|---|
| Applicant | : | LANGFANG LIUTAI FURNITURE CO., LTD |
| Address | : | ROOM 1009, BUILDING NO.6-1, SIJI HUA YU, ANCI DISTRICT, LANGFANG CITY, HEBEI PROVINCE.CHINA |
| Manufacturer | : | LANGFANG LIUTAI FURNITURE CO., LTD |
| Address | : | ROOM 1009, BUILDING NO.6-1, SIJI HUA YU, ANCI DISTRICT, LANGFANG CITY, HEBEI PROVINCE.CHINA |

## 1.2. General Description of EUT (Equipment Under Test)

| | | |
|---|---|---|
| EUT Name | : | LED strip remote control |
| Model No. | : | LB-01 |
| Serial No. | : | N/A |
| Trademark | : | N/A |
| Power Supply | : | DC 5V, 1A |

## 1.3. Block Diagram Showing the Configuration of System Tested




## 1.4. Description of Support Units

The EUT has been tested as an independent unit.

## 1.5. Performance Criterion

**Criterion A:** The equipment shall continue to operate as intended without operator intervention. No degradation of performance of loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended.

**Criterion B:** After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended.

**Criterion C:** Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions.

## 1.6. Test Facility

The testing report were performed by the Shenzhen HX Detect Certification Co., Ltd., in their facilities located at 206, Building 3A, Yintian Industrial Zone, Yantian Community, Xixiang Street, Bao'an District, Shenzhen.

# 2. Test Results Summary

| EMISSION (EN IEC 55015:2019/A11:2020) | | |
|---|---|---|
| **Description of test item** | **Standards** | **Results** |
| Conducted Disturbance at Mains Terminals | EN IEC 55015: 2019/A11: 2020 | N/A |
| Magnetic Emission | EN IEC 55015: 2019/A11: 2020 | Pass |
| Radiated Disturbance | EN IEC 55015: 2019/A11: 2020 | Pass |
| Harmonic Current Emissions | EN IEC 61000-3-2: 2019/A1: 2021 | N/A |
| Voltage Fluctuation and Flicker | EN 61000-3-3:2013/A2:2021 | N/A |
| **IMMUNITY (EN IEC 61547:2023)** | | |
| **Description of Test Item** | **Basic Standards** | **Results** |
| Electrostatic Discharge (ESD) | EN 61000-4-2: 2009 | Pass |
| Radio-frequency, Continuous Radiated Disturbance | EN IEC 61000-4-3: 2020 | Pass |
| EFT/B Immunity | EN 61000-4-4: 2012 | N/A |
| Surge Immunity | EN 61000-4-5: 2014/A1:2017 | N/A |
| Conducted RF Immunity | EN 61000-4-6: 2014 | N/A |
| Power Frequency Magnetic Field | EN 61000-4-8: 2010 | N/A |
| Voltage Dips and Interruptions, 100% Reduction | EN IEC 61000-4-11:2020 | N/A |
| Voltage Dips and Interruptions, 30% reduction | | N/A |

# 3. Test Equipment Used

| 3.1. Test Equipment Used to Measure Conducted Emission | | | | | |
|---|---|---|---|---|---|
| **No.** | **Equipment** | **Manufacturer** | **Model No.** | **Last Cal.** | **Cal. Interval** |
| HX-EMC001 | EMI Test Receiver | Rohde & Schwarz | ESCS30 | Dec. 26, 2025 | 1 Year |
| HX-EMC002 | AMN | Rohde & Schwarz | ENV216 | Dec. 26, 2025 | 1 Year |
| HX-EMC003 | AMN | SCHWARZBECK | NNBL 8226-2 | Dec. 26, 2025 | 1 Year |
| **3.2. Test Equipment Used to Measure Magnetic Field Emission** | | | | | |
| **No.** | **Equipment** | **Manufacturer** | **Model No.** | **Last Cal.** | **Cal. Interval** |
| HX-EMC001 | EMI Test Receiver | Rohde & Schwarz | ESCS30 | Dec. 26, 2025 | 1 Year |
| HX-EMC027 | Triple-Loop Antenna | EVERFINE | LLA-2 | Dec. 26, 2025 | 1 Year |
| **3.3. Test Equipment Used to Measure Radiated Emission** | | | | | |
| **No.** | **Equipment** | **Manufacturer** | **Model No.** | **Last Cal.** | **Cal. Interval** |
| HX-EMC004 | EMI Test Receiver | Rohde & Schwarz | ESI26 | Dec. 26, 2025 | 1 Year |
| HX-EMC005 | Bilog Antenna | SCHWARZBECK | VULB9163 | Dec. 26, 2025 | 1 Year |
| HX-EMC006 | Positioning Controller | C&C | CC-C-1F | N/A | N/A |
| **3.4. Test Equipment Used to Measure Harmonic Current/ Voltage Fluctuation and Flicker** | | | | | |
| **No.** | **Equipment** | **Manufacturer** | **Model No.** | **Last Cal.** | **Cal. Interval** |
| HX-EMC007 | Harmonic Flicker Test System | CI | 5001ix-CTS -400 | Dec. 26, 2025 | 1 Year |
| **3.5. Test Equipment Used to Measure Electrostatic Discharge Immunity** | | | | | |
| **No.** | **Equipment** | **Manufacturer** | **Model No.** | **Last Cal.** | **Cal. Interval** |
| HX-EMC008 | ESD Tester | TESEQ | NSG437 | Dec. 26, 2025 | 1 Year |
| **3.6. Test Equipment Used to Measure Conducted Immunity** | | | | | |
| **No.** | **Equipment** | **Manufacturer** | **Model No.** | **Last Cal.** | **Cal. Interval** |
| HX-EMC009 | RF Generator | FRANKONIA | CIT-10/75 | Dec. 26, 2025 | 1 Year |
| HX-EMC010 | Attenuator | FRANKONIA | 59-6-33 | Dec. 26, 2025 | 1 Year |
| HX-EMC011 | M-CDN | LUTHI | M2/M3 | Dec. 26, 2025 | 1 Year |
| HX-EMC012 | CDN | LUTHI | AF2 | Dec. 26, 2025 | 1 Year |

| | | | | | |
|---|---|---|---|---|---|
| HX-EMC013 | EM Injection Clamp | LUTHI | EM101 | Dec. 26, 2025 | 1 Year |
| **3.7. Test Equipment Used to Measure Radio Frequency Electromagnetic Fields Immunity** | | | | | |
| **No.** | **Equipment** | **Manufacturer** | **Model No.** | **Last Cal.** | **Cal. Interval** |
| HX-EMC014 | Signal Generator | Rohde & Schwarz | SMT03 | Dec. 26, 2025 | 1 Year |
| HX-EMC015 | Power Meter | Rohde & Schwarz | NRVD | Dec. 26, 2025 | 1 Year |
| HX-EMC016 | Voltage Probe | Rohde & Schwarz | URV5-Z2 | Dec. 26, 2025 | 1 Year |
| HX-EMC017 | Voltage Probe | Rohde & Schwarz | URV5-Z2 | Dec. 26, 2025 | 1 Year |
| HX-EMC018 | Power Amplifier | AR | 150W1000 | Dec. 26, 2025 | 1 Year |
| HX-EMC019 | Bilog Antenna | Chase | CBL6111C | Dec. 26, 2025 | 1 Year |
| **3.8. Test Equipment Used to Measure Electrical Fast Transient/Burst Immunity** | | | | | |
| **No.** | **Equipment** | **Manufacturer** | **Model No.** | **Last Cal.** | **Cal. Interval** |
| HX-EMC020 | Simulator | EMTEST | UCS500N5 | Dec. 26, 2025 | 1 Year |
| HX-EMC021 | Auto-transformer | EMTEST | V4780S2 | Dec. 26, 2025 | 1 Year |
| **3.9. Test Equipment Used to Measure Surge Immunity** | | | | | |
| **No.** | **Equipment** | **Manufacturer** | **Model No.** | **Last Cal.** | **Cal. Interval** |
| HX-EMC022 | Simulator | EMTEST | UCS500N5 | Dec. 26, 2025 | 1 Year |
| HX-EMC023 | Coupling Clamp | EMTEST | HFK | Dec. 26, 2025 | 1 Year |
| **3.10. Test Equipment Used to Measure Voltage Dips and Interruptions Immunity** | | | | | |
| **No.** | **Equipment** | **Manufacturer** | **Model No.** | **Last Cal.** | **Cal. Interval** |
| HX-EMC022 | Simulator | EMTEST | UCS500N5 | Dec. 26, 2025 | 1 Year |
| HX-EMC023 | Coupling Clamp | EMTEST | HFK | Dec. 26, 2025 | 1 Year |
| **3.11. Test Equipment Used to Measure Power frequency Magnetic Field** | | | | | |
| **No.** | **Equipment** | **Manufacturer** | **Model No.** | **Last Cal.** | **Cal. Interval** |
| HX-EMC026 | Power Frequency Magnetic Field Generator | EVERFINE | EMS61000-8K | Dec. 26, 2025 | 1 Year |

# 4. Conducted Emission Test

## 4.1. Test Standard and Limit

### 4.1.1. Test Standard

EN IEC 55015: 2019/A11: 2020.

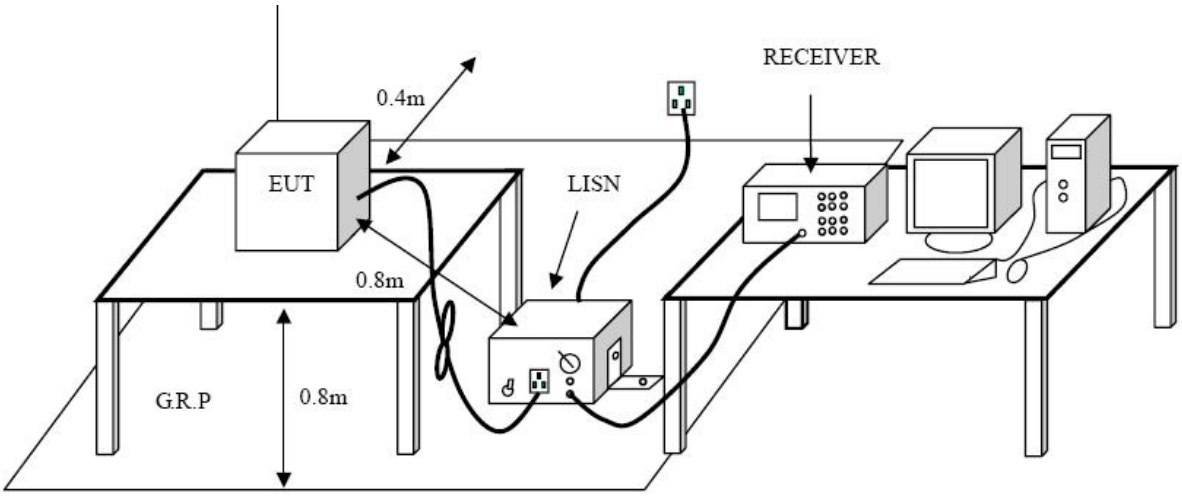
### 4.1.2. Test Limit

Conducted Disturbance Test Limit (Class B)

| Frequency | Maximum RF Line Voltage (dBμV) | |
|---|---|---|
| | Quasi-peak Level | Average Level |
| 9kHz~50kHz | 110 | -- |
| 50kHz ~150kHz | 90 to 80* | -- |
| 150kHz~500kHz | 66 ~ 56 * | 56 ~ 46 * |
| 500kHz~5MHz | 56 | 46 |
| 5MHz~30MHz | 60 | 50 |

**Remark: 1.** *Decreasing linearly with logarithm of the frequency
**2.** At the transition frequency, the lower limit applies.
**3.** For electrodeless lamps and luminaries, the limit in the frequency range of 2,51 MHz to 3,0 MHz is 73 dB(μV) quasi-peak and 63 dB(μV) average

## 4.2. Test Setup




## 4.3. Test Procedure

The EUT was placed 0.4 meters from the horizontal ground plane with EUT being connected to the power mains through a line impedance stabilization network (LISN). All other support equipments powered from additional LISN(s). The LISN provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.

Interconnecting cables that hang closer than 40 cm to the ground plane shall be folded back and forth in the center forming a bundle 30 to 40 cm long.

I/O cables that are not connected to a peripheral shall be bundled in the center. The end of the cable may be terminated, if required, using the correct terminating impedance. The overall length shall not exceed 1 m.

LISN at least 80 cm from nearest part of EUT chassis.

The bandwidth of EMI test receiver is set at 9kHz, and the test frequency band is from 9KHz to 30MHz.

## 4.4. Test Condition

| | | |
|---|---|---|
| Temperature | : | 25 ℃ |
| Relative Humidity | : | 48 % |
| Pressure | : | 1010 hPa |
| Test Power | : | / |

## 4.5. Test Data

The test item is not applicative.

# 5. Magnetic field emission Measurement

## 5.1. Test Standard and Limit

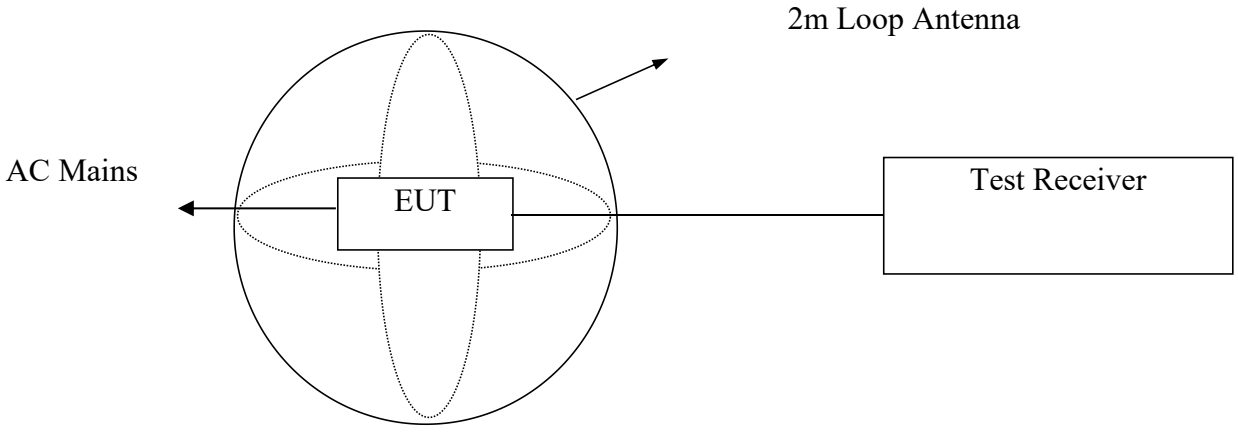
### 5.1.1. Test Standard

EN IEC 55015: 2019/A11: 2020.

### 5.1.2. Test Limit

| Frequency | | | Limits for loop diameter (dBμA) |
|---|---|---|---|
| | | | 2m |
| 9KHz | ~ | 70KHz | 88 |
| 70KHz | ~ | 150KHz | 88 ~ 58* |
| 150KHz | ~ | 2.2MHz | 58 ~ 26* |
| 2.2MHz | ~ | 3.0MHz | 58 |
| 3.0MHz | ~ | 30MHz | 22 |
| **Remark:** 1. At the transition frequency the lower limit applies.<br>2. * Decreasing linearly with logarithm of the frequency. | | | |

## 5.2. Test Setup




## 5.3. Test Procedure

The EUT is placed on a wood table in the center of a loop antenna. The induced current
in the loop antenna is measured by means of a current probe and the test receiver. Three field components are checked by means of a coaxial switch.

The frequency range from 9KHz to 30MHz is investigated. The receiver is measured with the quasi-peak detector. For frequency band 9KHz to 150KHz, the bandwidth of the field strength meter is set at 200Hz. For frequency band 150KHz to 30MHz, the bandwidth is set at 9KHz.

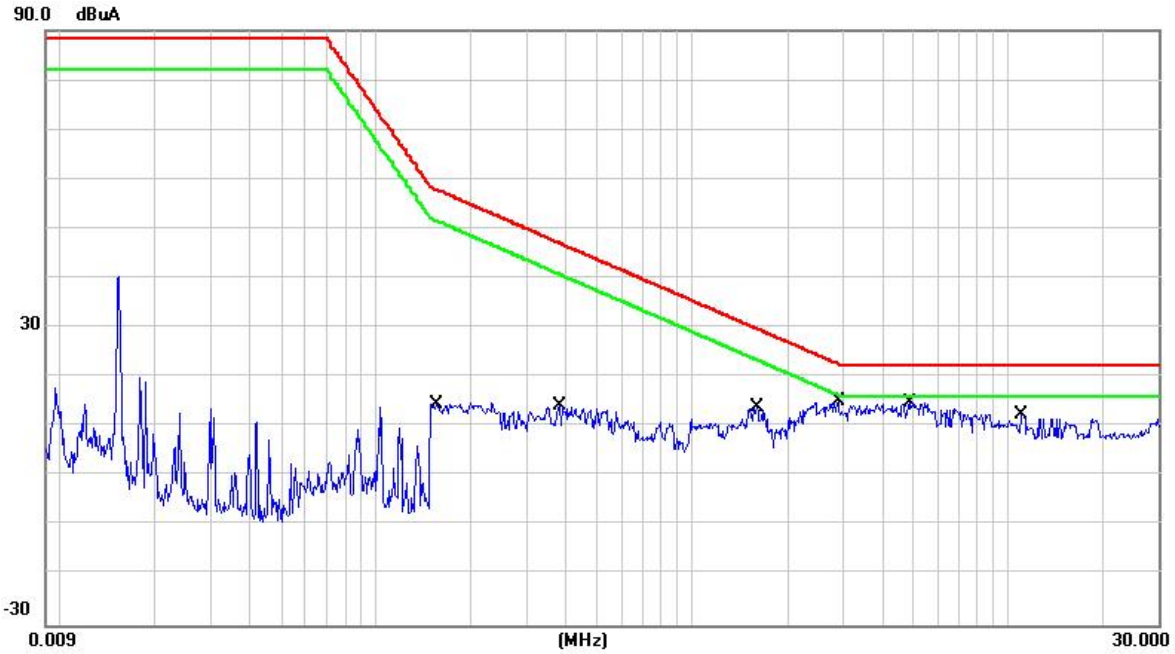
## 5.4. Test Condition

| | | |
|---|---|---|
| Temperature | : | 25 ℃ |
| Relative Humidity | : | 48 % |
| Pressure | : | 1010 hPa |
| Test Power | : | DC 5V |

## 5.5. Test Data

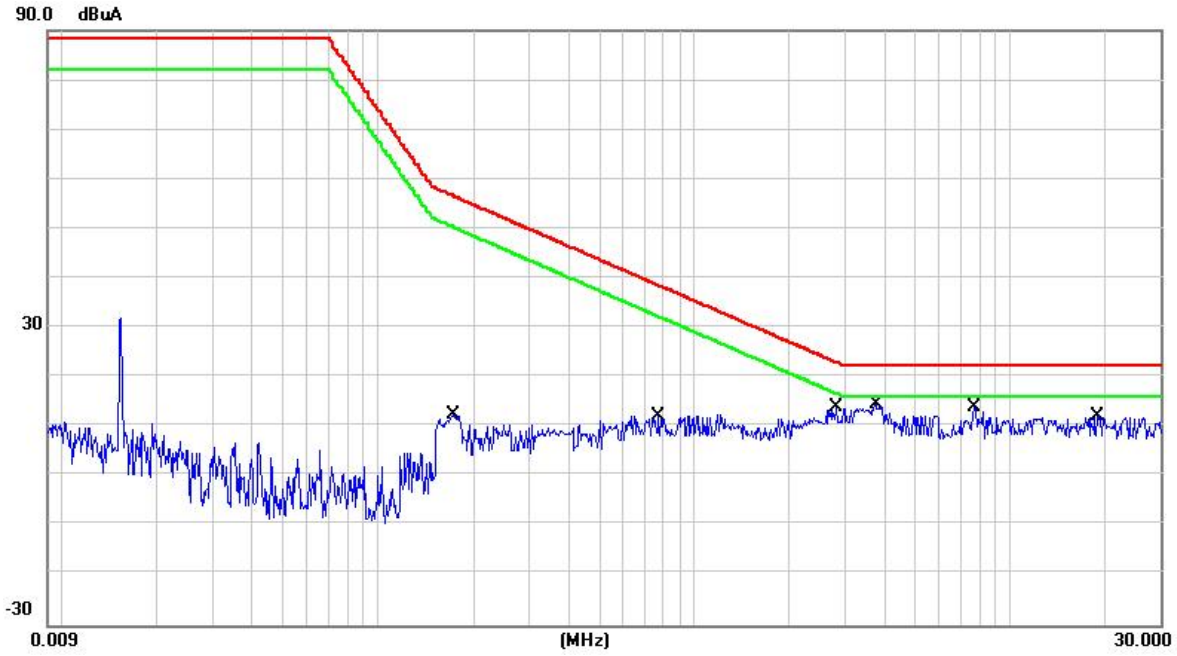
Please refer to the following pages.

***Operating Mode: ON***
***Test Specification: X Direction***



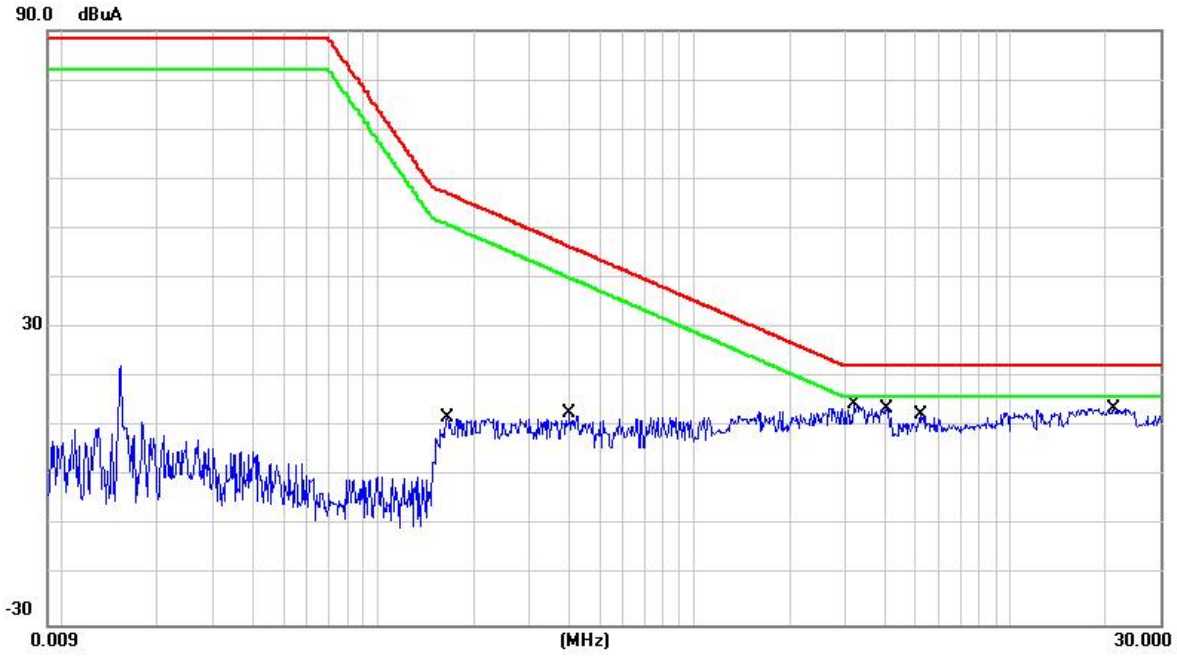

| No. | Mk. | Freq. | Reading Level | Correct Factor | Measure-ment | Limit | Over | | |
|---|---|---|---|---|---|---|---|---|---|
| | | MHz | dBuA | dB | dBuA | dBuA | dB | Detector | Comment |
| 1 | | 0.1550 | -20.97 | 35.52 | 14.55 | 57.61 | -43.06 | QP | |
| 2 | | 0.3820 | -21.68 | 35.88 | 14.20 | 46.77 | -32.57 | QP | |
| 3 | | 1.6060 | -21.75 | 35.80 | 14.05 | 29.51 | -15.46 | QP | |
| 4 | | 2.9100 | -20.81 | 35.89 | 15.08 | 22.37 | -7.29 | QP | |
| 5 | * | 4.9260 | -21.31 | 36.09 | 14.78 | 22.00 | -7.22 | QP | |
| 6 | | 11.0820 | -23.24 | 35.56 | 12.32 | 22.00 | -9.68 | QP | |

***Operating Mode: ON***
***Test Specification: Y Direction***




| No. | Mk. | Freq. | Reading Level | Correct Factor | Measure-ment | Limit | Over | | |
|---|---|---|---|---|---|---|---|---|---|
| | | MHz | dBuA | dB | dBuA | dBuA | dB | Detector | Comment |
| 1 | | 0.1740 | -22.58 | 34.98 | 12.40 | 56.22 | -43.82 | QP | |
| 2 | | 0.7740 | -23.37 | 35.52 | 12.15 | 38.28 | -26.13 | QP | |
| 3 | | 2.8340 | -21.74 | 35.60 | 13.86 | 22.68 | -8.82 | QP | |
| 4 | * | 3.7900 | -20.95 | 35.60 | 14.65 | 22.00 | -7.35 | QP | |
| 5 | | 7.7940 | -20.58 | 34.42 | 13.84 | 22.00 | -8.16 | QP | |
| 6 | | 18.9260 | -23.65 | 35.75 | 12.10 | 22.00 | -9.90 | QP | |

***Operating Mode: ON***
***Test Specification: Z Direction***




| No. | Mk. | Freq. | Reading Level | Correct Factor | Measure-ment | Limit | Over | | |
|---|---|---|---|---|---|---|---|---|---|
| | | MHz | dBuA | dB | dBuA | dBuA | dB | Detector | Comment |
| 1 | | 0.1660 | -24.47 | 36.23 | 11.76 | 56.78 | -45.02 | QP | |
| 2 | | 0.4060 | -23.57 | 36.19 | 12.62 | 46.03 | -33.41 | QP | |
| 3 | * | 3.2340 | -21.78 | 36.28 | 14.50 | 22.00 | -7.50 | QP | |
| 4 | | 4.0980 | -22.46 | 36.20 | 13.74 | 22.00 | -8.26 | QP | |
| 5 | | 5.2300 | -23.60 | 36.14 | 12.54 | 22.00 | -9.46 | QP | |
| 6 | | 21.4860 | -21.43 | 35.02 | 13.59 | 22.00 | -8.41 | QP | |

# 6. Radiated Disturbance Test

## 6.1. Test Standard and Limit

### 6.1.1. Test Standard

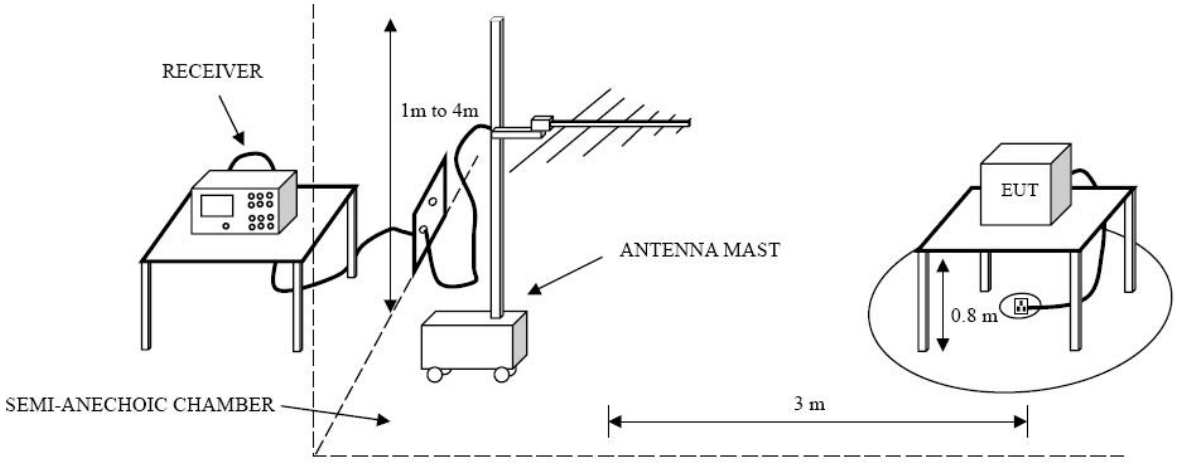
EN IEC 55015: 2019/A11: 2020

### 6.1.2. Test Limit

Radiated Disturbance Test Limit (Class B)

| Frequency | Limit (dBμV/m) |
|---|---|
| | Quasi-peak Level |
| 30MHz~230MHz | 40 |
| 230MHz~300MHz | 47 |
| **Remark:** 1. The lower limit shall apply at the transition frequency.<br>2. The test distance is 3m. | |

## 6.2. Test Setup




## 6.3. Test Procedure

The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3m. The table was rotated 360 degrees to determine the position of the highest radiation.

The height of the equipment or of the substitution antenna shall be 0.8 m; the height of the test antenna shall vary between 1 m to 4 m. Both horizontal and vertical polarizations of the antenna are set to make the measurement.

The initial step in collecting radiated emission data is a spectrum analyzer peak detector mode pre-scanning the measurement frequency range. Significant peaks are then marked and then Quasi Peak detector mode re-measured.

If the Peak Mode measured value compliance with and lower than Quasi Peak Mode

Limit, the EUT shall be deemed to meet QP Limits and then no additional QP Mode measurement performed.

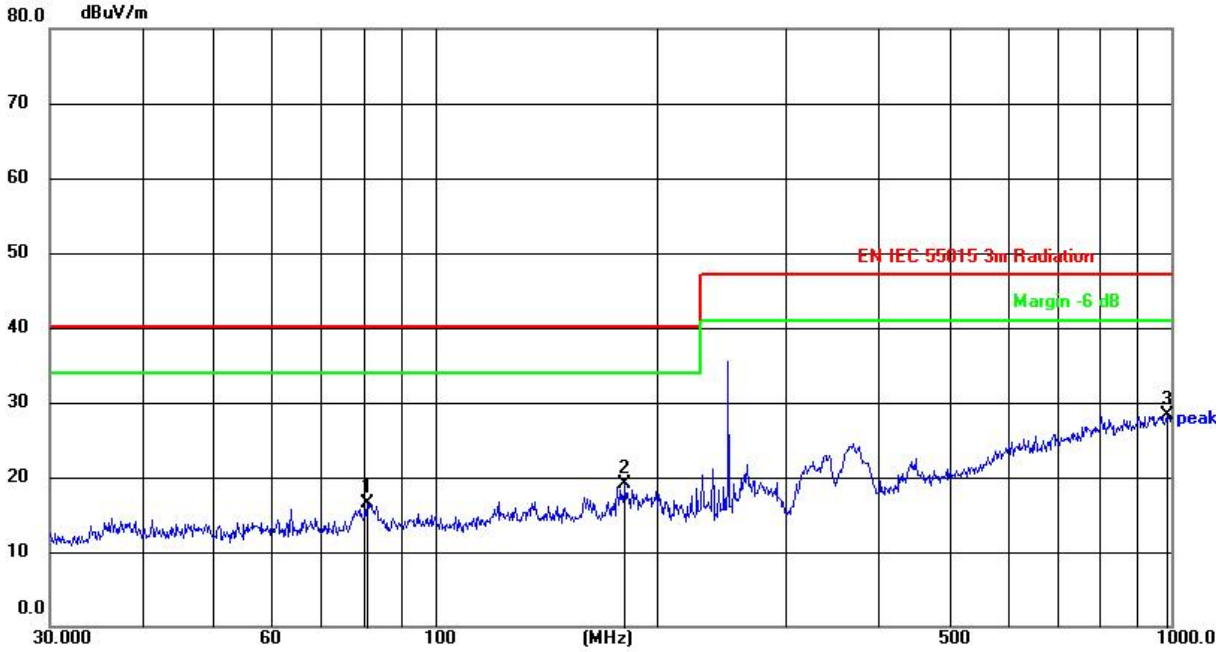
## 6.4. Test Condition

| | | |
|---|---|---|
| Temperature | : | 25 ℃ |
| Relative Humidity | : | 48 % |
| Pressure | : | 1010 hPa |
| Test Power | : | DC 5V |

## 6.5. Test Data

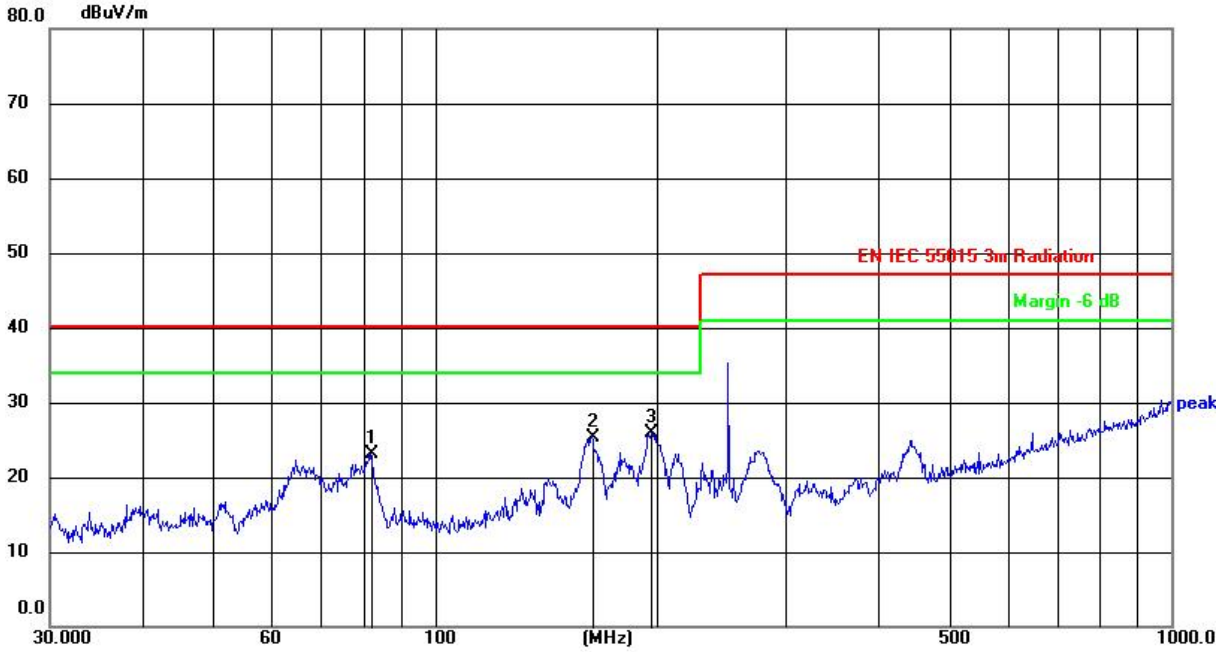
Please refer to the following pages.

***Operating Mode: ON***
***Test Specification: Horizontal***




| No. | Frequency (MHz) | Reading (dBuV) | Factor (dB/m) | Level (dBuV/m) | Limit (dBuV/m) | Margin (dB) | Detector | Height (cm) | Azimuth (deg.) | P/F | Remark |
|---|---|---|---|---|---|---|---|---|---|---|---|
| 1 | 80.9274 | 37.05 | -20.48 | 16.57 | 40.00 | -23.43 | peak | | | | |
| 2 | 181.2834 | 37.31 | -18.12 | 19.19 | 40.00 | -20.81 | peak | | | | |
| 3 | 986.0716 | 33.82 | -5.58 | 28.24 | 47.00 | -18.76 | peak | | | | |

***Operating Mode: ON***
***Test Specification: Vertical***




| No. | Frequency (MHz) | Reading (dBuV) | Factor (dB/m) | Level (dBuV/m) | Limit (dBuV/m) | Margin (dB) | Detector | Height (cm) | Azimuth (deg.) | P/F | Remark |
|---|---|---|---|---|---|---|---|---|---|---|---|
| 1 | 81.7833 | 43.35 | -20.26 | 23.09 | 40.00 | -16.91 | peak | | | | |
| 2 | 163.1818 | 44.15 | -18.75 | 25.40 | 40.00 | -14.60 | peak | | | | |
| 3 | 196.5098 | 44.66 | -18.83 | 25.83 | 40.00 | -14.17 | peak | | | | |

# 7. Electrostatic Discharge Immunity Test

## 7.1. Test Requirements

### 7.1.1. Test Standard

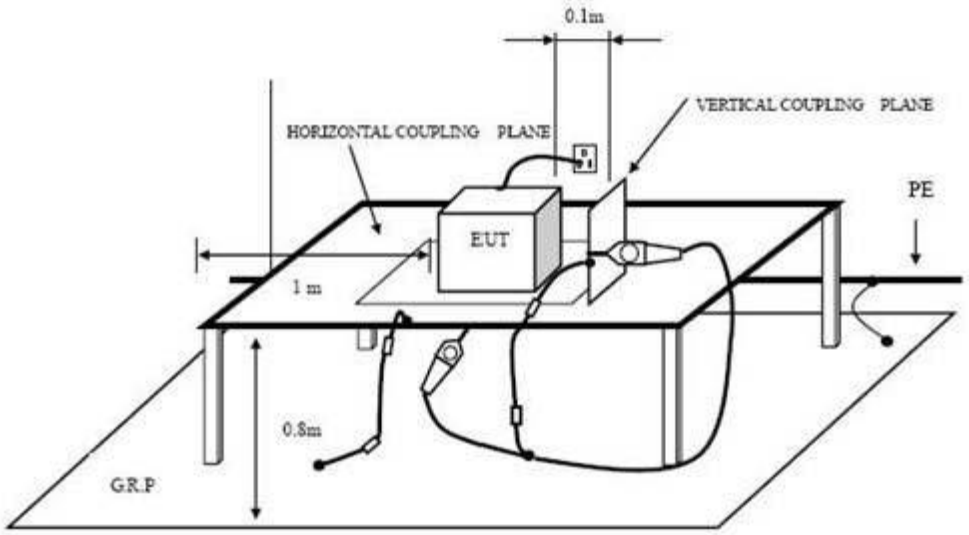
EN IEC 61547:2023 (EN 61000-4-2: 2009)

### 7.1.2. Test Level

| Level | Test Voltage Contact Discharge (kV) | Test Voltage Air Discharge (kV) |
|---|---|---|
| 1 | ±2 | ±2 |
| 2 | ±4 | ±4 |
| 3 | ±6 | ±8 |
| 4 | ±8 | ±15 |
| X | Special | Special |

### 7.1.3. Performance criterion: **B**

## 7.2. Test Setup




INDIRECT DISCHARGE SETUP

## 7.3. Test Procedure

### 7.3.1. Air Discharge:

This test is done on a non-conductive surface. The round discharge tip of the discharge electrode shall be approached as fast as possible to touch the EUT. After each discharge, the discharge electrode shall be removed from the EUT. The generator is then re-triggered for a new single discharge and repeated 10 times for

each pre-selected test point. This procedure shall be repeated until all the air discharge completed.

7.3.2. Contact Discharge:

All the procedure shall be same as air discharge. Except that the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.

7.3.3. Indirect discharge for horizontal coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied at the front edge of each HCP opposite the center point of each unit (if applicable) of the EUT and 0.1m from the front of the EUT. The long axis of the discharge electrode shall be in the plane of the HCP and perpendicular to its front edge during the discharge.

7.3.4. Indirect discharge for vertical coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, is placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges shall be applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are completely illuminated.

## 7.4. Test Data

Please refer to the following page.

# Electrostatic Discharge Test Result

| | | | |
|---|---|---|---|
| EUT | : LED strip remote control | M/N | : LB-01 |
| Temperature | : 22℃ | Humidity | : 50% |
| Power supply | : DC 5V | Test Mode | : Normal |

Criterion: B

Air Discharge: ±8kV Contact Discharge: ±4kV

For each point positive 10 times and negative 10 times discharge.

| **Location** | **Kind**<br>A-Air Discharge<br>C-Contact Discharge | **Result** |
|---|---|---|
| Non-conductive Enclosure | A | PASS |
| Slots of EUT | A | PASS |
| Button | A | PASS |
| Conductive enclosure | C | PASS |
| Screw | C | PASS |
| HCP | C | PASS |
| VCP of front | C | PASS |
| VCP of rear | C | PASS |
| VCP of left | C | PASS |
| VCP of right | C | PASS |

**Remark:**

# 8. Radiated Electromagnetic Field Immunity Test

## 8.1. Test Requirements

### 8.1.1. Test Standard

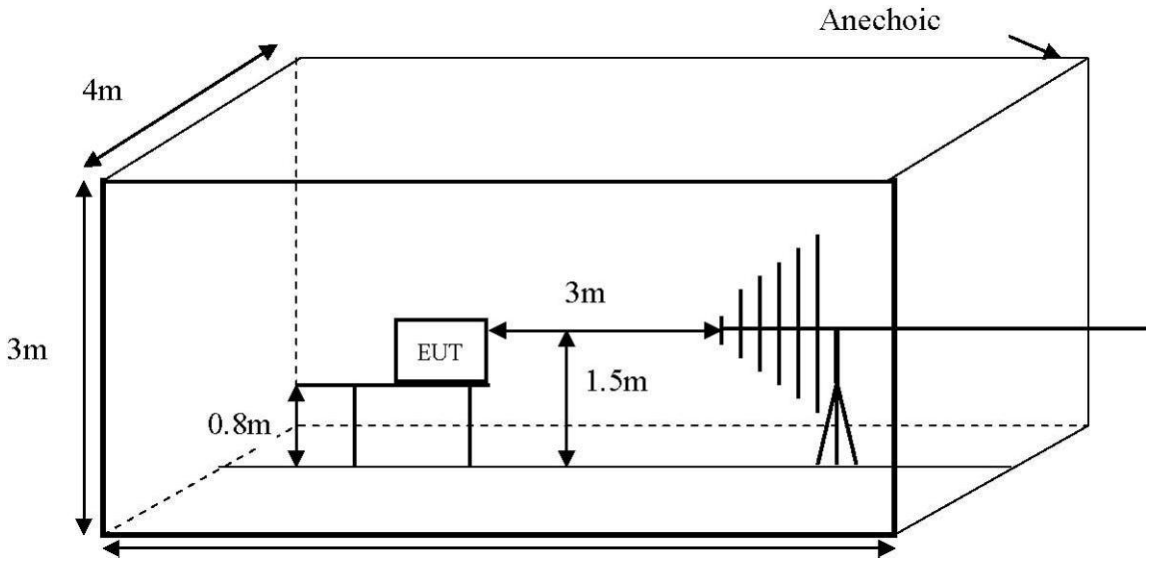
EN IEC 61547:2023 (EN IEC 61000-4-3: 2020)

### 8.1.2. Test Level

| Level | Field Strength V/m |
|---|---|
| 1 | 1 |
| 2 | 3 |
| 3 | 10 |
| X | Special |

### 8.1.3. Performance criterion: **A**

## 8.2. Test Setup




## 8.3. Test Procedure

The EUT are placed on a table, which is 0.8 meter high above the ground. The EUT is set 3 meters away from the transmitting antenna, which is mounted on an antenna tower. Both horizontal and vertical polarization of the antenna is set on test. Each of the four sides of the EUT must be faced this transmitting antenna and measured individually.

In order to judge the EUT performance, a camera is used to monitor its screen.

All the scanning conditions are as following:

| Condition of Test | Remark |
|---|---|
| Fielded strength | 3V/m (Severity Level 2) |
| Radiated signal | Modulated |
| Scanning frequency | 80-1000MHz |
| Sweep time of radiated | 0.0015 Decade/s |
| Dwell time | 1 Sec. |

## 8.4. Test Data

Please refer to the following page.

# RF Field Strength Susceptibility Test Results

| | | | |
|---|---|---|---|
| EUT | : LED strip remote control | M/N | : LB-01 |
| Temperature | : 22℃ | Humidity | : 50% |
| Power supply | : DC 5V | Test Mode | : Normal |

Criterion: A

Modulation: Unmodulated

Pulse: AM 1KHz 80%

| | Frequency Rang 1 | | Frequency Rang 2 | |
|---|---|---|---|---|
| | 80~1000MHz | | / | |
| | Horizontal | Vertical | Horizontal | Vertical |
| Front | PASS | PASS | / | / |
| Right | PASS | PASS | / | / |
| Rear | PASS | PASS | / | / |
| Left | PASS | PASS | / | / |

**Remark:**

# 9. Photographs - Constructional Details

**Photo 1 Appearance of EUT**

**Photo 2 Appearance of EUT**

**Photo 3 Inside of EUT**

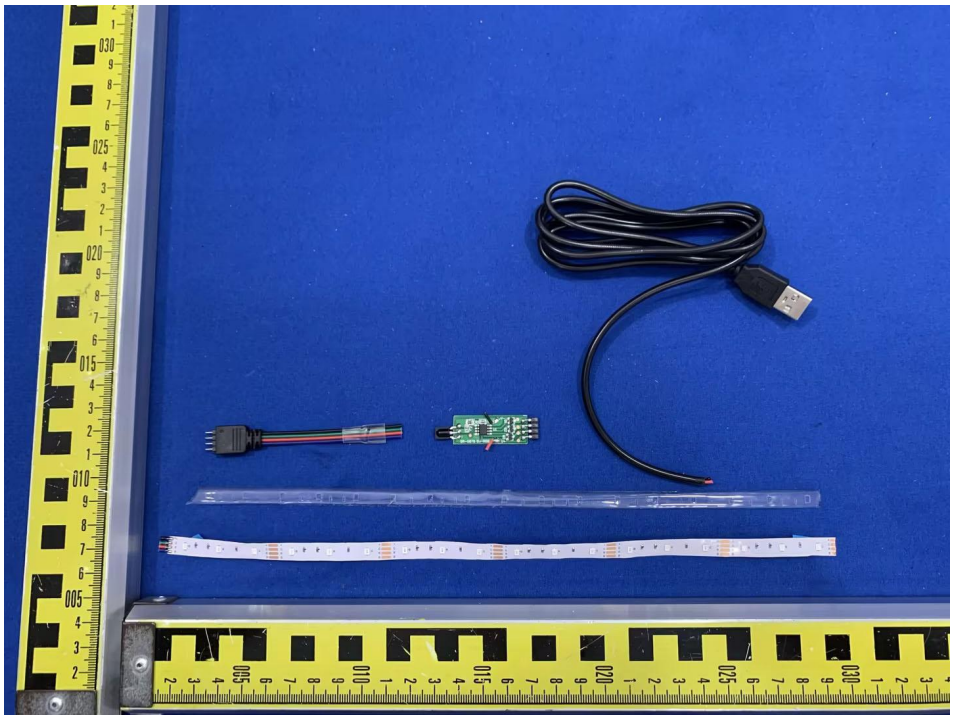


**Photo 4 Inside of EUT**

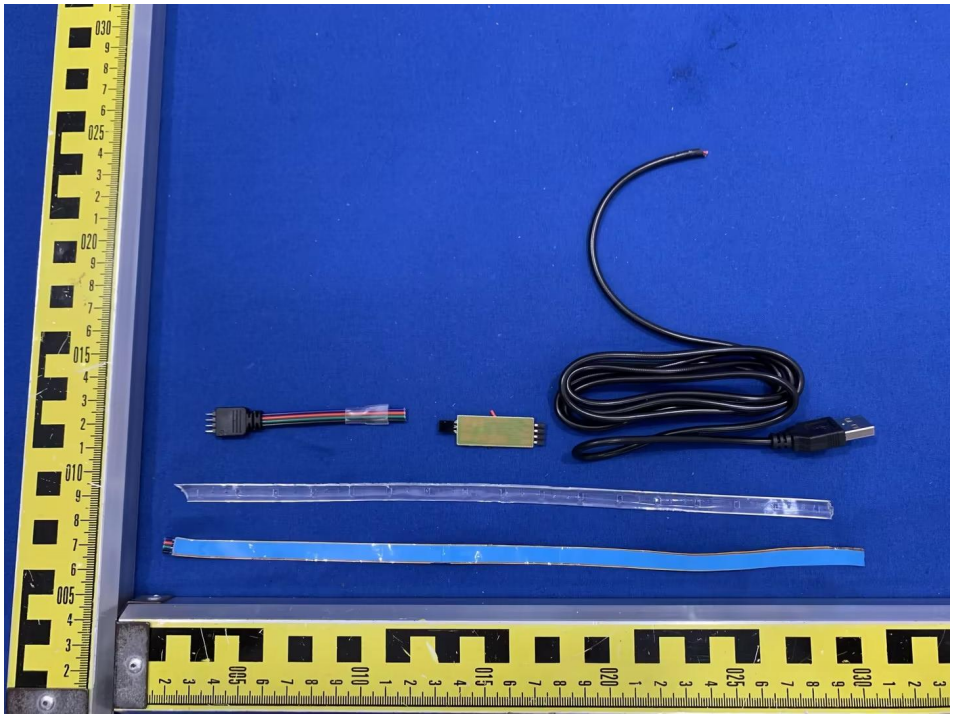


**Photo 5 Appearance of PCB**

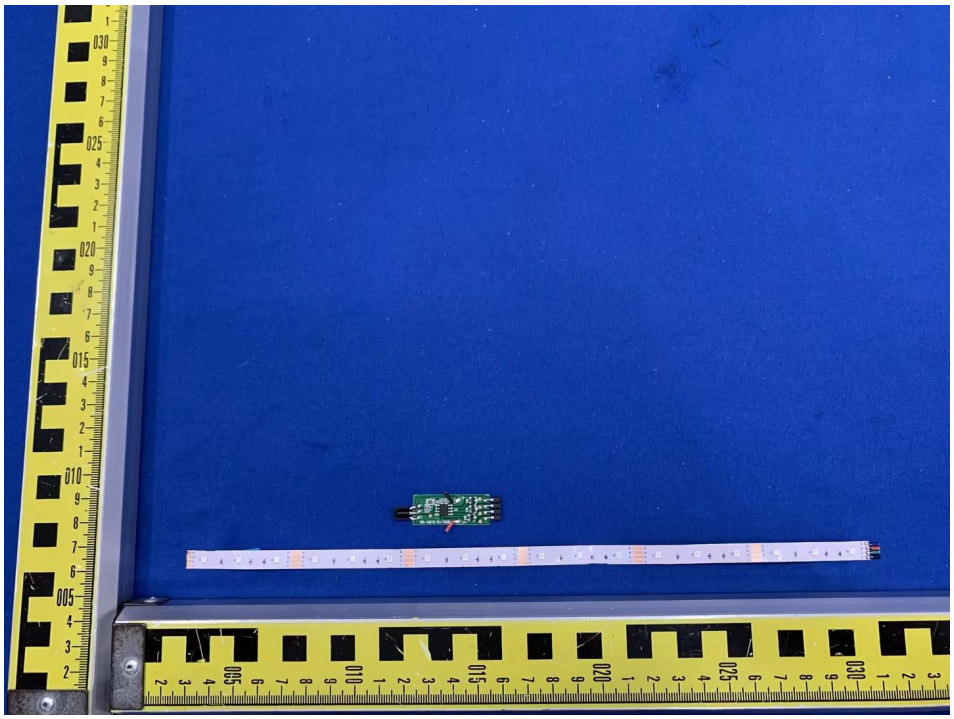
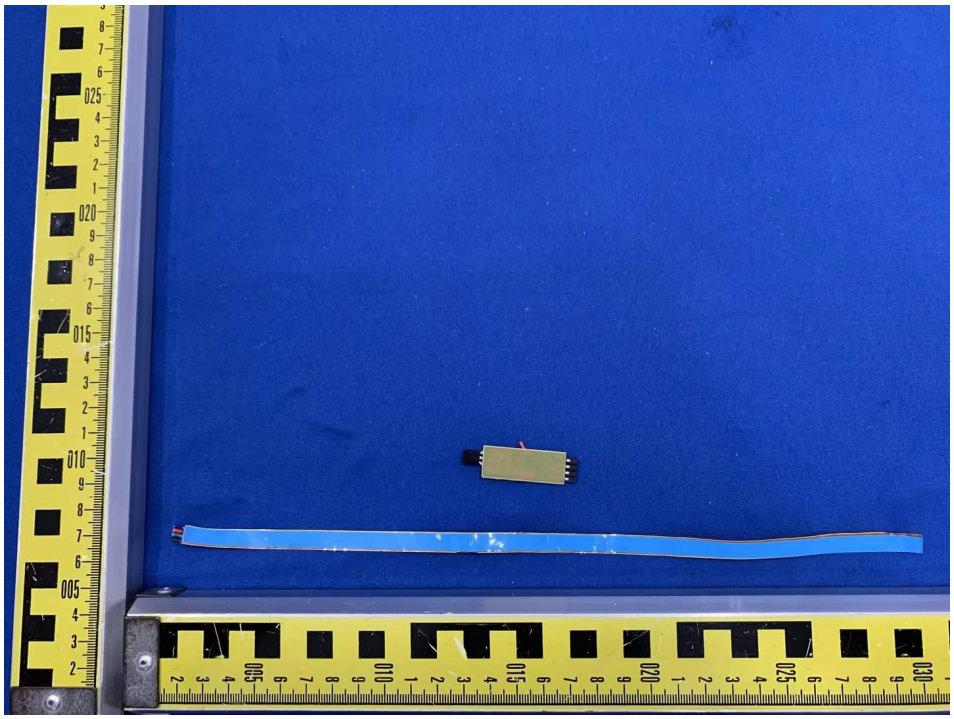


**Photo 6 Appearance of PCB**



**END OF REPORT**